

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10539366	TIEKE ET AL.
	Examiner	Art Unit
	ANEETA PATANKAR	4134

SEARCHED

Class	Subclass	Date	Examiner
369	59.11, 59.12	4/2/2008	AVP

SEARCH NOTES

Search Notes	Date	Examiner
East	4/2/2008	AVP
Inventor Search	4/3/2008	AVP
Consulted with Joseph Haley	4/2/2008	AVP
Consulted with Wayne Young	4/2/2008	AVP
EAST	10/23/08	A.P.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/A. P./
Examiner.Art Unit 2627